Switchable Terahertz Metamaterials: Using the Insulator-Metal Transition of Vanadium Dioxide to Activate Metamaterial Properties

Fei Yan¹, Edward P. J. Parrott¹, Georges Humbert², Aurelian Crunteanu², and

Emma Pickwell-MacPherson¹

¹Department of Electronic Engineering, The Chinese University of Hong Kong, Shatin, Hong Kong ²XLIM UMR 7252, CNRS/University of Limoges, 123 av. Albert Thomas, 87060, Limoges, France

*Abstract***—Terahertz (THz) metamaterials have recently attracted much interest due to their ability to tune propagation properties using sub-wavelength structures. In this paper we demonstrate the first metamaterial device developed by patterning a vanadium dioxide (VO2) wire-grid structure onto a c-sapphire substrate. Temperature and polarization dependent THz time-domain spectroscopy transmission measurements are taken to evaluate the device performance as a function of the metamaterial parameters. The transmission variance with polarization is enhanced by increasing the filling factor of the wire-grid structure.**

I. INTRODUCTION AND BACKGROUND

ERAHERTZ (THz) wave technology has many important applications in areas such as non-destructive sensing, material characterization, biomedical imaging and high-speed communication. This in turn drives an increasing need for passive and active THz optical components such as modulators, switches, and filters. Metamaterial inspired devices are one potential solution to realize these components as the structure of the metamaterial can be tuned to produce a desired property. Several groups have studied the use of metal gratings [1] to manipulate the polarization of terahertz waves. However, active devices for THz wave polarization modulation are very limited. "Active" metamaterial devices have been proposed that employ metallic structures such as split ring resonators atop tunable substrates [2]. Such devices can alter the frequency and intensity of optical absorption features but the metamaterial property itself cannot be switched off. An ability such as this may be realized by developing a metamaterial structure using a compound that can be switched from a metallic to a non-metallic state. T

Vanadium dioxide (VO_2) experiences an ultrafast insulator-to-metal (IM) phase transition at \sim 340 K. Based on this unique material property, active THz modulators and filters have been demonstrated using $VO₂$ by means of temperature control [3]. In this paper, we report a THz metamaterial employing 200 nm thick $VO₂$ wire-grids with micrometer period and width on top of c-sapphire substrate. Such a design allows us to activate the metamaterial properties from a completely passive state to a state displaying polarization sensitive transmission as the temperature passes through the IM phase transition.

II. EXPERIMENTAL RESULTS AND DISCUSSION

The VO₂ wire-grids were fabricated by photolithography and etching technique of the 200 nm thick (d) $VO₂$ thin films that fabricated by pulsed laser deposition (PLD) method (see Fig. 1) on c-sapphire substrates. The details can be found in previous works [4]. Figs. 2 (a) and (b) show the optical images of the $VO₂$ wire-grids. The period (P) of both $VO₂$ wire-grids is 10 μ m, and the width (W) is about 1 and 2 μ m, respectively, with the filling factor of 10% and 20%, respectively.

Fig. 1 Schematic diagram of the fabrication process for VO₂ wire-grids on c-sapphire substrates.

Fig. 2 Optical images of (a) $10/1 \mu m$, and (b) $10/2 \mu m$ VO₂ wire-grid.

 The temperature and polarization dependency of the terahertz transmission of 200 nm thick \overline{VO}_2 wire grids with 10/1 and 10/2 μm (period/width) grating patterns deposited on c-sapphire substrates were measured using our free-space terahertz system. Fig. 3 shows the temperature dependent normalized amplitude transmission for 0.6 THz frequency waves polarized at an angle of 0° and 90° to the VO₂ wire-gird direction. The normalized amplitude transmission of the 90° oriented wave (open triangles and squares) remains $\sim 100\%$ for both $VO₂$ wire-grid gratings when the temperature increases from 60 to 80 °C ($t_{90°/80°C}$). In contrast, the normalized amplitude transmission of the 0° oriented wave (solid triangles and squares) decreases from $\sim 100\%$ to $\sim 74\%$ and \sim 37% ($t_{0^{\circ}/80^{\circ}C}$) for the 10/1 μ m and 10/2 μ m wire-grid grating, respectively. This corresponds to the transition from the insulating $VO₂$ phase to the conducting $VO₂$ phase [5]. As we can see, the polarization modulation depth (MD_p) (Eq. 1)

$$
MD_{p} = \frac{t_{90^{\circ}/80^{\circ}C} - t_{0^{\circ}/80^{\circ}C}}{t_{90^{\circ}/80^{\circ}C}}
$$
 (1)

of VO₂ wire-grid at 80 °C is improved from \sim 26% to \sim 63% when the filling factor is increased from 10% to 20% due to the stronger absorption of the THz waves by the wider $VO₂$ wires. However, there is still a higher transmission for THz waves oriented at an angle of 0° to the metallic VO₂ wire-gird direction than the metal wire-grid structures [6, 7]. The reason is that the conductivity of metallic $VO₂$ is much lower than that of metals [8], and the THz waves polarized parallel to the metallic $VO₂$ wires are not completely reflected or absorbed. Therefore, the performance of this type of THz wave polarization modulator can also be improved through increasing the conductivity of metallic $VO₂$ wires by optimizing the fabrication process.

III. CONCLUSIONS

These $VO₂$ wire-grids with micrometer scale period and width are to our knowledge the first broadband metamaterials developed using only $VO₂$ and have potential applications in active THz polarization modulators. By increasing the filling factor from 10% to 20%, the polarization modulation depth is improved from 26% to 63%. The performance can be further improved by optimizing the material quality and structural parameters.

Temperature (°C)

Fig. 3 Temperature dependent normalized amplitude transmission for 0.6 THz frequency waves oriented at an angle of 0° and 90° to the wire-grid direction for (a) $10/1$ um, and (b) $10/2$ um VO₂ wire-grid.

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